



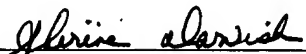
1FW
PATENTS
Attorney Docket No. SMY-111.01
SUN040079/SPL

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	
David L. Detlefs)	
)	Art Unit: Not yet assigned
Application No: 10/799,187)	
)	Confirmation No.: Not yet assigned
Filed: March 12, 2004)	
)	Examiner: Not yet assigned
For: CONCURRENT-MARKING-)	
INITIATION HEURISTIC)	

CERTIFICATE OF MAILING

I hereby certify that the following paper is being deposited with the United States Postal Service as first-class mail in an envelope addressed to Mail Stop Amendment Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on July 12, 2004.


Shirine M. Darvish

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INFORMATION-DISCLOSURE STATEMENT

Applicant hereby brings to the Examiner's attention the references listed on the accompanying form PTO-1449. A copy of each listed non-U.S. Patent reference is enclosed.

To the extent required by 37 C.F.R. §1.98(a)(3), Applicant has described what Applicant considers to be the relevance of any foreign-language reference.

Please charge any additional fee occasioned by this paper to our Deposit Account

No. 06-1448, Reference SMY-111.01.

Respectfully submitted,

A handwritten signature in black ink, appearing to read 'J. Born', written over a horizontal line.

Joseph H. Born, Reg. No. 28,283
Attorney for Applicants
Tel. No. (617) 832-1134
Fax. No. (617) 832-7000

Date: July 12, 2004
Customer No: 25181
Patent Group
Foley Hoag, LLP
155 Seaport Blvd.
Boston, MA 02210-2600

Form PTO-1449

**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION**
(Use several sheets if necessary)
Docket Number (Optional)
SMY-111.01Application Number
10/799,187Applicant
David L. DetlefsFiling Date
March 12, 2004Group Art Unit
Not yet assigned**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	US 6,434,576	08/13/02	Alexander T. Garthwaite	707	206	08/19/99
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS*(Including Author, Title, Date, Pertinent Pages Etc.)*

	AQ	BEN-YITZHAK, Ori, et al. "An Algorithm for Parallel Incremental Compaction," In Proceedings of 2002 International Symposium on Memory Management, ACM, 2002, pp. 100-105.
	AR	LANG, Bernard and DUPONT, Francis. "Incremental Incrementally Compacting Garbage Collection," In Programming of Future Generation Computers II, Elsevier, 1988, pp. 163-182.
	AS	JONES, Richard and LINS, Rafael. "Garbage Collection Algorithms for Automatic Dynamic Memory Management," John Wiley & Sons Ltd., Copyright 1996, West Sussex, England, Chapter 7, pp. 143-181.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Form PTO-1449

**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION***(Use several sheets if necessary)*Docket Number (Optional)
SMY-111.01Application Number
10/799,187Applicant
David L. DetlefsFiling Date
March 12, 2004Group Art Unit
Not yet assigned**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	BA					
	BB					
	BC					
	BD					
	BE					
	BF					
	BG					
	BH					
	BI					
	BJ					
	BK					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	BL						
	BM						
	BN						
	BO						
	BP						

OTHER DOCUMENTS*(Including Author, Title, Date, Pertinent Pages Etc.)*

	BQ	BACON, David E., et al. "The Metronome: A Simpler Approach to Garbage Collection in Real-Time Systems," R. Meersman and Z. Tari (Eds.): OTM Workshops 2003, LNCS 2889, pp. 466-478, 2003.
	BR	
	BS	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.